

<b>Notice of References Cited</b>	Application/Control No. 10/723,673		Applicant(s)/Patent Under Reexamination WOLMAN ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0156339 A1	08-2004	Urquhart et al.	370/334
*	B	US-2003/0174690 A1	09-2003	Benveniste, Mathilde	370/350
	C	US-			
	D	US-			
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	F	US-			
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	K	US-			
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	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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